Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination VAN DE HEUVEL ET AL.	
10511215		
Examiner	Art Unit	
Obeid, Mamon	3621	

SEARCHED							
Class	Subclass	Date	Examiner				
705	50-79	09/19/2007	M.O				
380	239-242	09/19/2007	M.O				

SEARCH NOTES					
Search Notes	Date	Examiner			
East	09/19/2007	M.O			
IEEE Xplore	09/19/2007	M.O			
Google	09/19/2007	M.O			
Discussed claims withPrimary Examiner Bradley Bayat	09/19/2007	M.O			

INTERFERENCE SEARCH						
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